

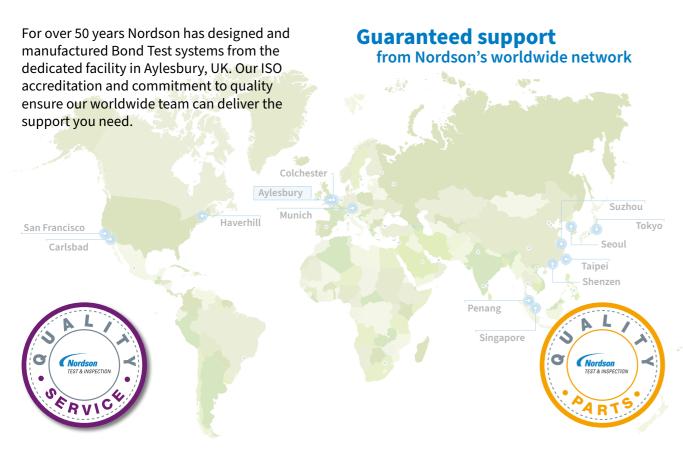
# **4600** Series

**Automated Bondtesters** 



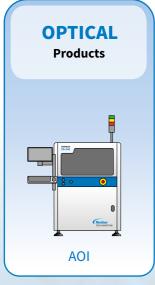
# The Electronics People

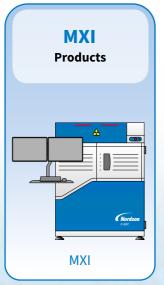
## **Data Integrity With Automation**



Nordson Corporation is a worldwide industrial technology company with over \$2 billion in annual revenues and a presence in 30+ different countries. We are leaders in mechanical testing and optical, X-ray and acoustic inspection.











### **Life With Automation**

Every operator touch-point is an opportunity to degrade measurement spread. Ensure the most accurate results with operator-free automation.



### Repeatable results every time

The 100 nm resolution rapid and closed loop motion system ensures the test tool is precise and never misses. Operators cannot match the accuracy and consistency of the test results.



#### **Data is everything**

Achieve maximum data integrity and traceability with full barcode scanning support. Data is made available for your MES or factory host.



#### Remove the expert

Paragon™ software is easy to use, so you don't need to rely on expert operators to run the system.

An operator can easily manage multiple systems rather than a single manual machine.



Load large batches of samples and benefit from robotic handling to load, align and transfer each device to the bondtester.



#### Improve tool ROI

High quality test capture is standard. Start the test, attend to other work, and return to review the full batch of test results. No inspection required.



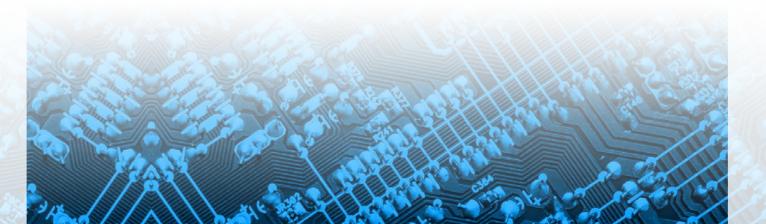
#### **Ultimate product safety**

Protect your wafers and lead frames from static and physical damage with robotic handling. There is no risk of losing a batch and no need to ever repeat a test.



#### **Maximum UPH**

Large testing envelope eliminates the need to index large parts and fit more in each batch. Increase test efficiency and throughput with the 50 mm/s table speed and camera-assisted automation.



### We've Got It Covered

### **Micro-electronics**

- Test every interconnect on a device
  - Lead frames and strips
  - Package substrates
  - BGA
  - MEMS



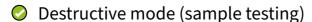


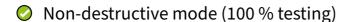
Electronics must be tested to industry standards for all of the above applications.

### **Battery**

Automate battery interconnect strength testing to ensure maximum automotive safety.

For battery systems the intercell connection technology requires mechanical testing in either:

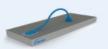


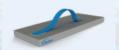


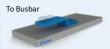






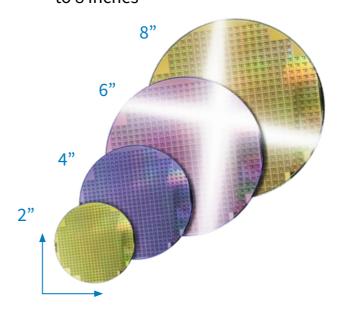




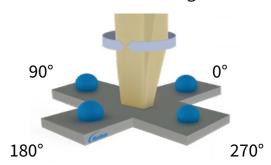


### Wafer level

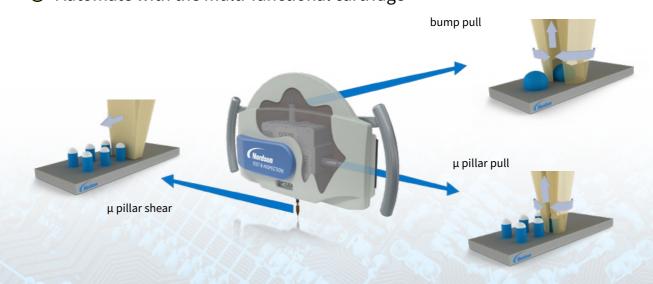
Test wafers from 2 inches to 8 inches



- Silicon, glass, laminate, composite, compound and warped wafers
- O Pillars and bumps <50 μm
- Test in any direction with the rotational shear cartridge



Automate with the multi-functional cartridge



### **Test The Extreme**







	Manual	4600	Handler Wafer / Lead Frame
Test repeatability	Rotary encoders	High resolution linear encoders	
Data integrity	Operator alignment	Fiducial recognition alignment	Fiducial recognition + OCR
Test procedure	Operator control	Automatic test	
Product safety	Manual load / unload		Automatic load / unload
Throughput and ROI	Variable (operator dependent)	$\bigcirc$	0000

### **Test More With Automation**

For the most complex devices with a high density of bumps or very fine pitch wires, automation is the only way to ensure maximum test accuracy.

Automation gives you the precision required to achieve the highest data integrity, test after test.

Small dimensions High density



Complex product Fine pitch





### **Data That Correlates**



The measurement cartridge is at the heart of every Bond Tester and is critical to achieving accurate and consistent results.

#### Future proof your bond testing systems:

Save costs and improve ROI - cartridges from older systems are compatible with the latest mainframes



### Specifications at a Glance

Testing

Test modes Manual + dual camera-assist automation

Test force 0.01 gf - 50 kgf

Multi-Function Cartridge (MFC) Pull, shear + CBP available

Imaging Autofocus + Compound Surface Imaging (CSI)

Process monitoring Auto failure mode ID + wire detection

Automation

Sample handling Wafer + strip auto-load

Traceability Wafer OCR + strip ID

Programming Pattern transfer + file import

Light tower 3 colour included

Factory communication Optional SECS / GEM & RS 232

**Axis Performance** 

XY speed and resolution

Step back accuracy (force dependent) ± 0.25 μm

System accuracy (force dependent)  $\pm 0.10\%$  - 0.05 % FSL

Axis travel (X x Y x Z) 450 mm x 410 mm x 75 mm

Up to 70 mm/s, 100 nm

Z speed and resolution 5 mm/s, 250 nm

Installation

Footprint (W x D x H) 1075 mm x 920 mm x 1000 mm

Weight 140 kg

Power supply 90-264 V, AC single phase

Pneumatic supply Min 4.0 Bar

Vacuum supply (4600-W only) Min 500 mm Hg

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Japan